

# Commercial Off-the-Shelf (COTS) for Higher Reliability Applications, C0G Dielectric, 10 – 200 VDC

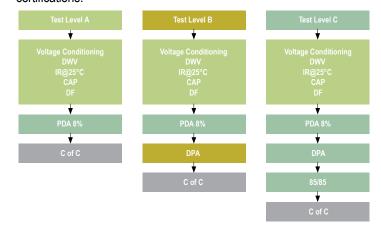
#### **Overview**

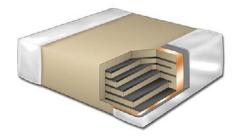
KEMET's COTS program is an extension of KEMET knowledge of high reliability test regimes and requirements. KEMET regularly supplies "up-screened" products by working with customer drawings and imposing specified design and test requirements. The COTS program offers the same high quality and high reliability components as up-screened products, but at a lower cost to the customer. This is accomplished by eliminating the need for customer-specific drawings to achieve the reliability level required for customer applications. A series of tests and inspections have been selected to provide the accelerated conditioning and 100% screening necessary to eliminate infant mortal failures from the population.

KEMET's COG dielectric features a 125°C maximum operating temperature and is considered "stable." The Electronics Components, Assemblies & Materials Association (EIA) characterizes COG dielectric as a Class I material. Components of this classification are temperature compensating and are suited for resonant circuit applications or those where Q and stability of capacitance characteristics are required. COG exhibits no change in capacitance with respect to time and voltage and boasts a negligible change in capacitance with reference to ambient

temperature. Capacitance change is limited to ±30 ppm/°C from -55°C to +125°C.

All COTS testing includes voltage conditioning and post-electrical testing as per MIL–PRF–55681. For enhanced reliability, KEMET also provides the following test level options and conformance certifications:





## **Ordering Information**

С	1206	Т	104	K	5	G	Α	С	TU
Ceramic	Case Size (L" x W")	Specification/ Series	Capacitance Code (pF)	Capacitance Tolerance <sup>1</sup>	Voltage	Dielectric	Failure Rate/Design	Termination Finish <sup>2</sup>	Packaging/Grade (C-Spec) <sup>3</sup>
	0402 0603 0805 1206 1210 1812 2220	T = COTS	2 Significant Digits + Number of Zeros Use 9 for 1.0 – 9.9 pF Use 8 for 0.5 – .99 pF ex. 2.2 pF = 229 ex. 0.5 pF = 508	$B = \pm 0.10 \text{ pF}$ $C = \pm 0.25 \text{ pF}$ $D = \pm 0.5 \text{ pF}$ $F = \pm 1\%$ $G = \pm 2\%$ $J = \pm 5\%$ $K = \pm 10\%$ $M = \pm 20\%$	8 = 10 V 4 = 16 V 3 = 25 V 6 = 35 V 5 = 50 V 1 = 100 V 2 = 200 V	G = COG	A = Testing per MIL-PRF- 55681 PDA 8% B= Testing per MIL-PRF- 55681 PDA 8%, DPA per EIA-469 C = Testing per MIL- PRF-55681 PDA 8%, DPA per EIA-469, Humidity per MIL-STD-202, Method 103, Condition A	C = 100% Matte Sn L = SnPb (5% minimum)	Blank = Bulk TU = 7" Reel Unmarked TM = 7" Reel Marked

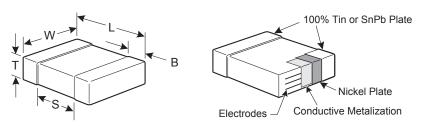
<sup>&</sup>lt;sup>1</sup> Additional capacitance tolerance offerings may be available. Contact KEMET for details.

<sup>&</sup>lt;sup>2</sup> Additional termination finish options may be available. Contact KEMET for details.

<sup>&</sup>lt;sup>3</sup> Additional reeling or packaging options may be available. Contact KEMET for details.



## **Dimensions – Millimeters (Inches)**



EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0402	1005	1.00 (.040) ± 0.05 (.002)	0.50 (.020) ± 0.05 (.002)		0.30 (.012) ± 0.10 (.004)	0.30 (.012)	Solder Reflow Only
0603	1608	1.60 (.063) ± 0.15 (.006)	0.80 (.032) ± 0.15 (.006)		0.35 (.014) ± 0.15 (.006)	0.70 (.028)	
0805	2012	2.00 (.079) ± 0.20 (.008)	1.25 (.049) ± 0.20 (.008)		0.50 (0.02) ± 0.25 (.010)	0.75 (.030)	Solder Wave or Solder Reflow
1206	3216	3.20 (.126) ± 0.20 (.008)	1.60 (.063) ± 0.20 (.008)	See Table 2 for Thickness	0.50 (0.02) ± 0.25 (.010)		
1210	3225	3.20 (.126) ± 0.20 (.008)	2.50 (.098) ± 0.20 (.008)	1	0.50 (0.02) ± 0.25 (.010)	NI/A	
1812	4532	4.50 (.177) ± 0.30 (.012)	3.20 (.126) ± 0.30 (.012)		0.60 (.024) ± 0.35 (.014)	N/A	Solder Reflow Only
2220	5650	5.70 (.224) ± 0.40 (.016)	5.00 (.197) ± 0.40 (.016)		0.60 (.024) ± 0.35 (.014)		

#### **Benefits**

- -55°C to +125°C operating temperature range
- Voltage conditioning and post-electrical testing per MIL-PRF-55681, Paragraph 4.8.3.1, Standard Voltage Conditioning
- Destructive Physical Analysis (DPA) per EIA–469
- Humidity, steady state, low voltage (85/85) per MIL–STD–202, Method 103, Condition A
- · Certificate of compliance
- RoHS Compliant (excluding SnPb end metallization option)
- EIA 0402, 0603, 0805, 1206, 1210, 1812, and 2220 case sizes
- DC voltage ratings of 10 V, 16 V, 25 V, 50 V, 100 V, and 200 V
- Capacitance offerings ranging from 0.5 pF up to 0.47 μF
- Available capacitance tolerances of ±0.10 pF, ±0.25 pF, ±0.5 pF, ±1%, ±2%, ±5%, ±10%, and ±20%

- No piezoelectric noise
- Extremely low ESR and ESL
- High thermal stability
- · High ripple current capability
- Preferred capacitance solution at line frequencies and into the MHz range
- No capacitance change with respect to applied rated DC voltage
- Negligible capacitance change with respect to temperature
- · No capacitance decay with time
- · Non-polar device, minimizing installation concerns
- SnPb end metallization option available upon request (5% minimum)

## **Applications**

Typical applications include military, space quality and high reliability electronics.



#### **Qualification/Certification**

Commercial Grade products are subject to internal qualification. Details regarding test methods and conditions are referenced in Table 4, Performance & Reliability.

## **Environmental Compliance**

Pb-Free and RoHS Compliant.



#### **Electrical Parameters/Characteristics**

Item	Parameters/Characteristics
Operating Temperature Range	-55°C to +125°C
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	±30 ppm/°C
Aging Rate (Maximum % Capacitance Loss/Decade Hour)	0%
Dielectric Withstanding Voltage (DWV)	250% of rated voltage (5 ±1 seconds and charge/discharge not exceeding 50 mA)
Dissipation Factor (DF) Maximum Limit @ 25°C	0.1%
Insulation Resistance (IR) Limit @ 25°C	1,000 megohm microfarads or 100 GΩ (Rated voltage applied for 120 ±5 seconds @ 25°C)

To obtain IR limit, divide  $M\Omega$ - $\mu$ F value by the capacitance and compare to  $G\Omega$  limit. Select the lower of the two limits.

Capacitance and dissipation factor (DF) measured under the following conditions:

Note: When measuring capacitance it is important to ensure the set voltage level is held constant. The HP4284 and Agilent E4980 have a feature known as Automatic Level Control (ALC). The ALC feature should be switched to "ON."

#### **Post Environmental Limits**

	High Temperatu	ire Life, Biased	<b>Humidity, Mois</b>	ture Resistance	
Dielectric	Rated DC Voltage	Capacitance Value	Dissipation Factor (Maximum %)	Capacitance Shift	Insulation Resistance
C0G	All	All	0.5	0.3% or ±0.25 pF	10% of Initial Limit

<sup>1</sup> MHz ±100 kHz and 1.0 Vrms ±0.2 V if capacitance ≤ 1,000 pF

<sup>1</sup> kHz  $\pm 50$  Hz and 1.0 Vrms  $\pm 0.2$  V if capacitance > 1,000 pF



## Table 1A – Capacitance Range/Selection Waterfall (0402 – 0805 Case Sizes)

		Series			C04	<del>4</del> 02					CO	603					CO	805		
0	Сар	Voltage Code	8	4	3	5	1	2	8	4	3	5	1	2	8	4	3	5	1	2
Capacitance	Code	Voltage DC	10	16	25	50	100	200	9	9	25	20	8	200	9	16	25	20	9	200
		Capacitance Tolerance	erance See Table 2 for Chip Thickness Dime									ss Codes ensions								
0.50-0.75 pF	508-758	B C D	BB	BB	BB	BB			СВ	СВ	СВ	СВ	СВ	СВ	DC	DC	DC	DC	DC	DC
1.0-9.1 pF 10-91 pF	109-919 100-910	B C D F G J K M	BB BB	BB BB	BB BB	BB BB			CB CB	CB CB	CB CB	CB CB	CB CB	CB CB	DC DC	DC DC	DC DC	DC DC	DC DC	DC DC
100-180 pF	100-910	F G J K M	BB	BB	BB	BB	BB		CB	CB	CB	CB	CB	CB	DC	DC	DC	DC	DC	DC
200-430 pF	201-431	F G J K M	BB	BB	BB	BB	BB		CB	CB	CB	CB	CB	CB	DC	DC	DC	DC	DC	DC
470 pF	471	F G J K M	BB	BB	BB	BB	BB		СВ	CB	CB	CB	CB		DC	DC	DC	DC	DC	DD
510-820 pF	511-821	F G J K M	BB	BB	BB	BB	BB		СВ	СВ	СВ	CB	СВ		DC	DC	DC	DC	DC	DC
910 pF	911	F G J K M	ВВ	BB	ВВ	BB	ВВ		СВ	СВ	СВ	СВ	СВ		DC	DC	DC	DC	DD	DD
1,000 pF	102	F G J K M	BB	BB	BB	BB	BB		СВ	СВ	СВ	СВ	СВ		DC	DC	DC	DC	DD	DD
1,100 pF	112	F G J K M	BB	BB	BB	BB			СВ	СВ	СВ	СВ	СВ		DC	DC	DC	DC	DC	
1,200 pF	122	F G J K M	BB	BB	BB	BB			СВ	СВ	СВ	СВ	СВ		DC	DC	DC	DC	DC	
1,300 pF	132	F G J K M	BB	BB	BB	BB			СВ	СВ	СВ	СВ	СВ		DD	DD	DD	DD	DD	
1,500 pF	152	F G J K M	BB	BB	BB	BB			СВ	СВ	СВ	СВ	СВ		DD	DD	DD	DD	DD	
1,600 pF	162	F G J K M	BB	BB	BB				СВ	СВ	CB	CB	CB		DD	DD	DD	DD	DD	
1,800 pF	182	F G J K M	BB	BB	BB				СВ	СВ	СВ	CB	СВ		DD	DD	DD	DD	DD	
2,000 pF	202	F G J K M	BB	BB	BB				СВ	СВ	СВ	СВ	СВ		DC	DC	DC	DC	DC	
2,200 pF	222	F G J K M	BB	BB	BB				СВ	СВ	СВ	CB	СВ		DC	DC	DC	DC	DC	
2,400 pF	242	F G J K M							СВ	СВ	CB	CB	CB		DC	DC	DC	DC	DC	
2,700 pF	272	F G J K M							CB	CB	CB	CB	CB		DC	DC	DC	DC	DC	
3,000 pF	302	F G J K M							CB CB	CB CB	CB CB	CB CB	CB CB		DD	DD	DD	DD DD	DC DC	
3,300 pF	332 362								CB	CB	CB	CB	CB		DD DD	DD DD	DD DD	DD	DC	
3,600 pF 3,900 pF	392	F G J K M							CB	CB	CB	CB	CB		DE	DE	DE	DE	DC	
4,300 pF	432	F G J K M							CB	CB	CB	CB	CB		DE	DE	DE	DE	DC	
4,700 pF	472	F G J K M							CB	CB	CB	CB	CB		DE	DE	DE	DE	DC	
5,100 pF	512	F G J K M							СВ	CB	CB	CB	OB		DE	DE	DE	DE	DC	
5,600 pF	562	F G J K M							СВ	CB	CB	CB			DC	DC	DC	DC	DC	
6,200 pF	622	F G J K M							СВ	СВ	СВ	CB			DC	DC	DC	DC	DC	
6,800 pF	682	F G J K M							СВ	СВ	СВ	СВ			DC	DC	DC	DC	DC	
7,500 pF	752	F G J K M							СВ	СВ	СВ				DC	DC	DC	DC	DC	
8,200 pF	822	F G J K M							СВ	СВ	СВ				DC	DC	DC	DC	DC	
9,100 pF	912	F G J K M							СВ	СВ	CB				DC	DC	DC	DC	DC	
10,000 pF	103	F G J K M							СВ	СВ	СВ				DC	DC	DC	DC	DD	
12,000 pF	123	F G J K M							СВ	СВ	СВ				DC	DC	DC	DC	DE	
15,000 pF	153	F G J K M							СВ	СВ	СВ				DC	DC	DC	DD	DG	
18,000 pF	183	F G J K M													DC	DC	DC	DD		
22,000 pF	223	F G J K M													DD	DD	DD	DF		
27,000 pF	273	F G J K M													DF	DF	DF			
33,000 pF	333 393	F G J K M													DG DG	DG DG	DG DG			
39,000 pF 47,000 pF	473	F G J K M													DG	DG	DG			
56,000 pF	563	F G J K M													100	DG	DG			
68,000 pF	683	F G J K M																		
82,000 pF	823	F G J K M																		
0.10 µF	104	F G J K M																		
	0	Voltage DC	9	9	25	20	100	200	9	9	25	20	100	200	9	9	25	20	19	200
Capacitance	Cap Code	Voltage Code	8	4	3	5	1	2	8	4	3	5	1	2 8 4 3 5 1			2			
		Series			C04	402					C0	603					C0	805		

KEMET reserves the right to substitute product with an improved temperature characteristic, tighter capacitance tolerance and/or higher voltage capability within the same form factor (configuration and dimensions).

These products are protected under US Patents 7,172,985 & 7,670,981, other patents pending, and any foreign counterparts.



## Table 1B - Capacitance Range/Selection Waterfall (1206 - 2220 Case Sizes)

					Se	rie	5					<b>C</b> 1	206					<b>C</b> 1	210			(	C181	2	(	2220	0
Capacitance	Cap		,	Vol	tag	je C	od	е		8	4	3	5	1	2	8	4	3	5	1	2	5	1	2	3	1	2
Capacitance	Code			Vo	olta	ge	DC			10	16	25	50	100	200	9	16	22	20	100	200	50	100	200	20	100	200
					pac			•														ss C					
0.5-0.75 pF	508-758	В	С	D	ole	ran	ce							Se	e rar	oie z	tor C	nip i	nick	ness	Dime	ensic	ons				
0.75 pF	758	В	С	D																		İ					
1.0-9.1 pF	109-919	В	С	D						EB	EB	EB	EB	EB	EB	FB	FB	FB	FB	FB	FB						
10-91 pF	100-910				F	G	J	K	M	EB	EB	EB	EB	EB	EB	FB	FB	FB	FB	FB	FB						
100-430 pF	101-431				F	G	J	K	M	EB	EB	EB	EB	EB	EB	FB	FB	FB	FB	FB	FB		OD	OD			
470-910 pF 1,000 pF	471-911 102	l			F	G	J	K	M	EB EB	EB EB	EB EB	EB EB	EB EB	EB EE	FB FB	FB FB	FB FB	FB FB	FB FB	FB FB	GB GB	GB GB	GB GB			
1,100 pF	112				F	G	J	K	M	EB	EB	EB	EB	EB	EB	FB	FB	FB	FB	FB	FB	GB	GB	GB			
1,200 pF	122	İ			F	G	J	K	M	EB	EB	EB	EB	EB	EB	FB	FB	FB	FB	FB	FB	GB	GB	GB			
1,300 pF	132				F	G	J	K	М	EB	EB	EB	EB	EC	EC	FB	FB	FB	FB	FB	FC	GB	GB	GB			
1,500 pF	152				F	G	J	K	M	EB	EB	EB	EB	ED	EC	FB	FB	FB	FB	FB	FE	GB	GB	GB			
1,600 pF	162				F	G	J	K	M	EB	EB	EB	EB	ED	ED	FB	FB	FB	FB	FB	FE	GB	GB	GB			
1,800 pF	182				F	G	J	K	M	EB	EB EB	EB	EB EB	ED	ED	FB	FB FB	FB	FB	FB FC	FE FE	GB	GB	GB			
2,000 pF 2,200 pF	202 222				F	G	J	K	M	EB EB	EB	EB EB	EB	ED EE	ED ED	FB FB	FB	FB FB	FB FB	FC	FG	GB GB	GB GB	GB GB			
2,400 pF	242				F	G	J	K	M	EB	EB	EB	EB	EC	EC	FB	FB	FB	FB	FC	FC	OD.	OD	OB			
2,700 pF	272				F	G	J	K	M	EB	EB	EB	EB	EC	EC	FB	FB	FB	FB	FC	FC	GB	GB	GB	İ		
3,000 pF	302				F	G	J	K	М	EC	EC	EC	EC	EC		FB	FB	FB	FB	FC	FF						
3,300 pF	332				F	G	J	K	M	EC	EC	EC	EC	EE		FB	FB	FB	FB	FF	FF	GB	GB	GB			
3,600 pF	362				F	G	J	K	M	EC	EC	EC	EC	EE EF		FB	FB	FB	FB	FF	FF		OD	OD			
3,900 pF 4,300 pF	392 432				F	G	J	K	M M	EC EC	EC EC	EC EC	EC EC	EC		FB FB	FB FB	FB FB	FB FB	FF FF	FF FG	GB	GB	GB			
4,700 pF	472				F	G	J	K	M	EC	EC	EC	EC	EC		FF	FF	FF	FF	FG	FG	GB	GB	GD			
5,100 pF	512	ĺ			F	G	J	K	M	ED	ED	ED	ED	ED		FB	FB	FB	FB	FG	FG	"					
5,600 pF	562				F	G	J	K	M	ED	ED	ED	ED	ED		FB	FB	FB	FB	FG		GB	GB	GH			
6,200 pF	622				F	G	J	K	M	EB	EB	EB	EB	EB		FB	FB	FB	FB	FG							
6,800 pF	682	l			F	G	J	K	M	EB	EB	EB	EB	EB		FB	FB	FB	FB	FG		GB	GB	GJ	JE	JE	
7,500 pF 8,200 pF	752 822	l			F	G	J	K	M	EB EC	EB EC	EB EC	EB EC	EB EB		FC FC	FC FC	FC FC	FC FC	FC FC		GB	GH		JE	JE	
9,100 pF	912	l			F	G	J	K	M	EC	EC	EC	EC	EB		FE	FE	FE	FE	FE		00	OII		J	JE	
10,000 pF	103				F	G	J	K	M	ED	ED	ED	ED	EB		FF	FF	FF	FF	FF		GB	GH		JE	JE	
12,000 pF	123	l			F	G	J	K	M	EB	EB	EB	EB	EB		FG	FG	FG	FG	FB		GB	GG		JE	JE	
15,000 pF	153				F	G	J	K	M	EB	EB	EB	EB	EB		FG	FG	FG	FG	FB		GB	GB		JE	JE	
18,000 pF	183				F	G	J	K	M	EB	EB	EB	EB	EB		FB	FB	FB	FB	FB		GB	GB		JE	JE	
22,000 pF 27,000 pF	223 273				F	G	J	K	M	EB EB	EB EB	EB EB	EB EB	EC EE		FB FB	FB FB	FB FB	FB FB	FB FB		GB GB	GB GB		JE JE	JB JB	
33,000 pF	333	l			F	G	J	K	M	EB	EB	EB	EB	EE		FB	FB	FB	FB	FB		GB	GB		JB	JB	
39,000 pF	393	l			F	G	J	K	M	EC	EC	EC	EE	EH		FB	FB	FB	FB	FE		GB	GB		JB	JB	
47,000 pF	473	l			F	G	J	K	M	EC	EC	EC	EE	EH		FB	FB	FB	FB	FE		GB	GB		JB	JB	
56,000 pF	563				F	G	J	K	М	ED	ED	ED	EF			FB	FB	FB	FB	FF		GB	GB		JB	JB	
68,000 pF	683				F	G	J	K	M	EF	EF	EF	EH			FB	FB	FB	FC	FG		GB	GB		JB	JB	
82,000 pF	823				F	G	J	K	M	EH	EH	EH	EH			FC	FC	FC	FF	FH		GB	GB		JB	JB	
0.10 μF 0.12 μF	104 124				F	G	J	K	M	EH	EH	EH				FE FG	FE FG	FE FG	FG FH	FM		GB	GD		JB JB	JB JB	
0.12 μF	154				F	G	J	K	M							FH	FH	FH	FM			GD	GN		JB	JB	
0.18 µF	184				F	G	J	K	М							FJ	FJ	FJ				GH			JB	JD	
0.22 µF	224				F	G	J	K	М							FK	FK	FK				GK			JB	JD	
0.27 µF	274				F	G	J	K	M																JB	JF	
0.33 μF 0.39 μF	334 394				F	G	J	K	M																JD JG	JG	
0.39 μF 0.47 μF	394 474				F	G	J	K	M																JG		
0.47 μΓ 0.56 μF	334				F	G	J	K	M																"		
0.68 µF	394				F	G	J	K	М																		
0.82 µF	474				F	G	J	K	M																		
	Сар				olta					9	9	25	20	9	200	2	16	25	20	190	200	20	5	200	20	9	200
Capacitance	Code			Vol	tag	je C	od	е		8	4	3	5	1	2	8	4	3	5	1	2	5	1	2	3	1	2
					Se	ries	<u> </u>					C1	206					C1:	210				C181	2		C2220	0

KEMET reserves the right to substitute product with an improved temperature characteristic, tighter capacitance tolerance and/or higher voltage capability within the same form factor (configuration and dimensions).

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**Table 2 – Chip Thickness/Packaging Quantities** 

Thickness	Case	Thickness ±	Paper C	uantity	Plastic (	Quantity
Code	Size	Range (mm)	7" Reel	13" Reel	7" Reel	13" Reel
BB	0402	$0.50 \pm 0.05$	10,000	50,000	0	0
СВ	0603	$0.80 \pm 0.07$	4,000	10,000	0	0
DC	0805	$0.78 \pm 0.10$	4,000	10,000	0	0
DD	0805	$0.90 \pm 0.10$	4,000	10,000	0	0
DE	0805	1.00 ± 0.10	0	0	2,500	10,000
DF	0805	1.10 ± 0.10	0	0	2,500	10,000
DG	0805	1.25 ± 0.15	0	0	2,500	10,000
EB	1206	$0.78 \pm 0.10$	4,000	10,000	4,000	10,000
EC	1206	$0.90 \pm 0.10$	0	0	4,000	10,000
ED	1206	1.00 ± 0.10	0	0	2,500	10,000
EE	1206	1.10 ± 0.10	0	0	2,500	10,000
EF	1206	1.20 ± 0.15	0	0	2,500	10,000
EH	1206	1.60 ± 0.20	0	0	2,000	8,000
FB	1210	0.78 ± 0.10	0	0	4,000	10,000
FC	1210	0.90 ± 0.10	0	0	4,000	10,000
FE	1210	1.00 ± 0.10	0	0	2,500	10,000
FF	1210	1.10 ± 0.10	0	0	2,500	10,000
FG	1210	1.25 ± 0.15	0	0	2,500	10,000
FH	1210	1.55 ± 0.15	0	0	2,000	8,000
GB	1812	1.00 ± 0.10	0	0	1,000	4,000
GD	1812	1.25 ± 0.15	0	0	1,000	4,000
GH	1812	1.40 ± 0.15	0	0	1,000	4,000
GG	1812	1.55 ± 0.10	0	0	1,000	4,000
GJ	1812	1.70 ± 0.15	0	0	1,000	4,000
JB	2220	1.00 ± 0.15	0	0	1,000	4,000
JE	2220	1.40 ± 0.15	0	0	1,000	4,000
Thickness	Case	Thickness ±	7" Reel	13" Reel	7" Reel	13" Reel
Code	Size	Range (mm)	Paper C	luantity	Plastic (	Quantity

Package quantity based on finished chip thickness specifications.



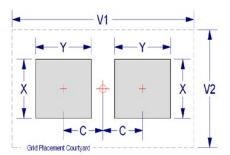
Table 3 - Chip Capacitor Land Pattern Design Recommendations per IPC-7351

EIA Size Code	Metric Size Code	ı	Maxi	sity Lev mum (N rotrusio	lost)	)	ı	Media	sity Lev an (Nor rotrusio			Density Level C: Minimum (Least) Land Protrusion (mm)					
Oouc	Oouc	С	Y	Х	V1	V2	С	Y	X	V1	V2	С	Y	X	V1	V2	
0402	1005	0.50	0.72	0.72	2.20	1.20	0.45	0.62	0.62	1.90	1.00	0.40	0.52	0.52	1.60	0.80	
0603	1608	0.90	1.15	1.10	4.00	2.10	0.80	0.95	1.00	3.10	1.50	0.60	0.75	0.90	2.40	1.20	
0805	2012	1.00	1.35	1.55	4.40	2.60	0.90	1.15	1.45	3.50	2.00	0.75	0.95	1.35	2.80	1.70	
1206	3216	1.60	1.35	1.90	5.60	2.90	1.50	1.15	1.80	4.70	2.30	1.40	0.95	1.70	4.00	2.00	
1210	3225	1.60	1.35	2.80	5.65	3.80	1.50	1.15	2.70	4.70	3.20	1.40	0.95	2.60	4.00	2.90	
1210¹	3225	1.50	1.60	2.90	5.60	3.90	1.40	1.40	2.80	4.70	3.30	1.30	1.20	2.70	4.00	3.00	
1812	4532	2.15	1.60	3.60	6.90	4.60	2.05	1.40	3.50	6.00	4.00	1.95	1.20	3.40	5.30	3.70	
2220	5650	2.75	1.70	5.50	8.20	6.50	2.65	1.50	5.40	7.30	5.90	2.55	1.30	5.30	6.60	5.60	

<sup>&</sup>lt;sup>1</sup> Only for capacitance values ≥ 22 μF

**Density Level A:** For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805, and 1206 case sizes.

**Density Level B:** For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes. **Density Level C:** For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC–7351).



## **Soldering Process**

Recommended Soldering Technique:

- Solder wave or solder reflow for EIA case sizes 0603, 0805, and 1206
- All other EIA case sizes are limited to solder reflow only

Recommended Soldering Profile:

KEMET recommends following the guidelines outlined in IPC/JEDEC J-STD-020



## Table 4 - Performance & Reliability: Test Methods and Conditions

Stress	Reference	Test or Inspection Method
Terminal Strength	JIS-C-6429	Appendix 1, Note: Force of 1.8 kg for 60 seconds.
Board Flex	JIS-C-6429	Appendix 2, Note: Standard termination system – 2.0 mm (minimum) for all except 3 mm for C0G. Flexible termination system – 3.0 mm (minimum).
		Magnification 50 X. Conditions:
Solderability	J-STD-002	a) Method B, 4 hours @ 155°C, dry heat @ 235°C
Solderability	J-31D-002	b) Method B @ 215°C category 3
		c) Method D, category 3 @ 260°C
Temperature Cycling	JESD22 Method JA-104	1,000 Cycles (-55°C to +125°C). Measurement at 24 hours +/- 2 hours after test conclusion.
Biased Humidity	MIL-STD-202 Method 103	Load Humidity: 1,000 hours 85°C/85% RH and rated voltage. Add 100 K ohm resistor. Measurement at 24 hours +/- 2 hours after test conclusion.  Low Volt Humidity: 1,000 hours 85°C/85% RH and 1.5 V. Add 100 K ohm resistor.  Measurement at 24 hours +/- 2 hours after test conclusion.
Moisture Resistance	MIL-STD-202 Method 106	t = 24 hours/cycle. Steps 7a and 7b not required. Unpowered.  Measurement at 24 hours +/- 2 hours after test conclusion.
Thermal Shock	MIL-STD-202 Method 107	-55°C/+125°C. Note: Number of cycles required – 300, maximum transfer time – 20 seconds, dwell time – 15 minutes. Air – Air.
High Temperature Life	MIL-STD-202 Method 108 /EIA-198	1,000 hours at 125°C (85°C for X5R, Z5U and Y5V) with 2 X rated voltage applied.
Storage Life	MIL-STD-202 Method 108	150°C, 0 VDC for 1,000 hours.
Vibration	MIL-STD-202 Method 204	5 g's for 20 min., 12 cycles each of 3 orientations. Note: Use 8" X 5" PCB 0.031" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10 – 2,000 Hz
Mechanical Shock	MIL-STD-202 Method 213	Figure 1 of Method 213, Condition F.
Resistance to Solvents	MIL-STD-202 Method 215	Add aqueous wash chemical, OKEM Clean or equivalent.

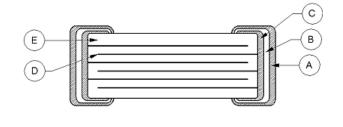
## **Storage and Handling**

Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature—reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. Temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 1.5 years of receipt.



#### Construction

Reference	lt	em	Material
А	Termination System	Finish	100% Matte Sn
В		Barrier Layer	Ni
С	, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	Base Metal	Cu
D	Inner E	Electrode	Ni
Е	Dielectr	ic Material	CaZrO <sub>3</sub>



Note: Image is exaggerated in order to clearly identify all components of construction.

## **Capacitor Marking (Optional):**

Laser marking option is not available on:

- C0G, Ultra Stable X8R and Y5V dielectric devices
- EIA 0402 case size devices
- EIA 0603 case size devices with Flexible Termination option.
- · KPS Commercial and Automotive grade stacked devices.

These capacitors are supplied unmarked only.



## **Tape & Reel Packaging Information**

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12 and 16 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.

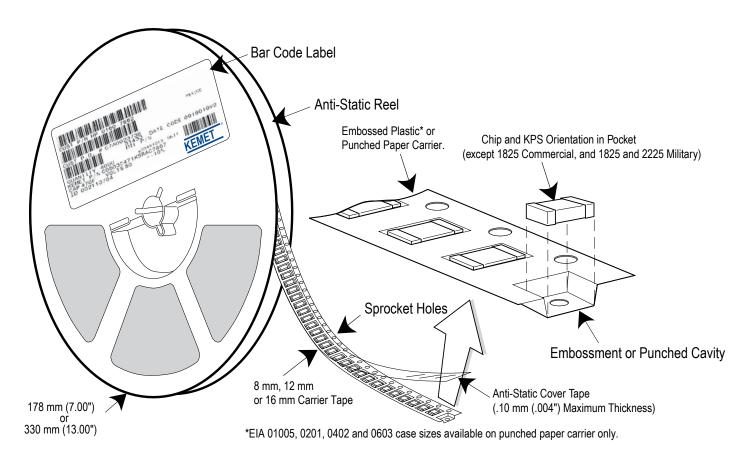


Table 5 – Carrier Tape Configuration – Embossed Plastic & Punched Paper (mm)

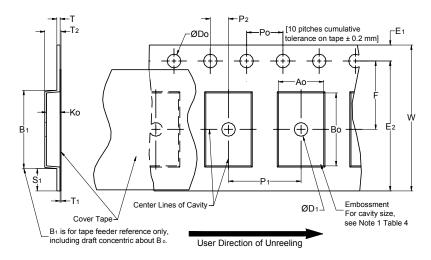
EIA Case Size	Tape Size (W)*	Pitch (P <sub>1</sub> )*
01005 – 0402	8	2
0603 – 1210	8	4
1805 – 1808	12	4
≥ 1812	12	8
KPS 1210	12	8
KPS 1812 & 2220	16	12
Array 0508 & 0612	8	4

<sup>\*</sup>Refer to Figures 1 & 2 for W and P, carrier tape reference locations.

<sup>\*</sup>Refer to Tables 6 & 7 for tolerance specifications.



## Figure 1 – Embossed (Plastic) Carrier Tape Dimensions



## Table 6 - Embossed (Plastic) Carrier Tape Dimensions

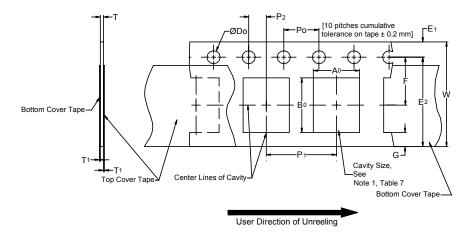
Metric will govern

	Constant Dimensions — Millimeters (Inches)														
Tape Size	D <sub>0</sub>	D <sub>1</sub> Minimum Note 1	E <sub>1</sub>	P <sub>0</sub>	P <sub>2</sub>	R Reference Note 2	S <sub>1</sub> Minimum Note 3	T Maximum	T <sub>1</sub> Maximum						
8 mm		1.0 (0.039)				25.0 (0.984)									
12 mm	1.5 +0.10/-0.0 (0.059 +0.004/-0.0)	1.5	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	30	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)						
16 mm		(0.059)				(1.181)									
			Variable Dime	ensions — Mil	limeters (Inch	es)									
Tape Size	Pitch	B <sub>1</sub> Maximum Note 4	E <sub>2</sub> Minimum	F	P <sub>1</sub>	T <sub>2</sub> Maximum	W Maximum	$A_0,B_0$	& K <sub>0</sub>						
8 mm	Single (4 mm)	4.35 (0.171)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	2.5 (0.098)	8.3 (0.327)								
12 mm	Single (4 mm) & Double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5 ±0.05 (0.217 ±0.002)	8.0 ±0.10 (0.315 ±0.004)	4.6 (0.181)	12.3 (0.484)	Not	e 5						
16 mm	Triple (12 mm)	12.1 (0.476)	14.25 (0.561)	7.5 ±0.05 (0.138 ±0.002)	12.0 ±0.10 (0.157 ±0.004)	4.6 (0.181)	16.3 (0.642)								

- 1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of embossment location and hole location shall be applied independent of each other.
- 2. The tape with or without components shall pass around R without damage (see Figure 6).
- 3. If S, < 1.0 mm, there may not be enough area for cover tape to be properly applied (see EIA Standard 481 paragraph 4.3 section b).
- 4. B, dimension is a reference dimension for tape feeder clearance only.
- 5. The cavity defined by  $A_0$ ,  $B_0$  and  $K_0$  shall surround the component with sufficient clearance that:
  - (a) the component does not protrude above the top surface of the carrier tape.
  - (b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
  - (c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3).
  - (d) lateral movement of the component is restricted to 0.5 mm maximum for 8 and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4).
  - (e) for KPS Series product, A<sub>a</sub> and B<sub>a</sub> are measured on a plane 0.3 mm above the bottom of the pocket.
  - (f) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.



## Figure 2 – Punched (Paper) Carrier Tape Dimensions



## Table 7 – Punched (Paper) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)						
Tape Size	D <sub>0</sub>	E <sub>1</sub>	P <sub>0</sub>	P <sub>2</sub>	T <sub>1</sub> Maximum	G Minimum	R Reference Note 2
8 mm	1.5 +0.10 -0.0 (0.059 +0.004 -0.0)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	0.10 (0.004) Maximum	0.75 (0.030)	25 (0.984)
	Variable Dimensions — Millimeters (Inches)						
Tape Size	Pitch	E2 Minimum	F	P <sub>1</sub>	T Maximum	W Maximum	$A_0B_0$
8 mm	Half (2 mm)	6.25	3.5 ±0.05	2.0 ±0.05 (0.079 ±0.002)	1.1	8.3 (0.327)	Note 1
8 mm	Single (4 mm)	(0.246)	(0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	(0.098)	8.3 (0.327)	Note I

- 1. The cavity defined by  $A_{o}$ ,  $B_{o}$  and T shall surround the component with sufficient clearance that:
  - a) the component does not protrude beyond either surface of the carrier tape.
  - b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
  - c) rotation of the component is limited to 20° maximum (see Figure 3).
  - d) lateral movement of the component is restricted to 0.5 mm maximum (see Figure 4).
  - e) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.
- 2. The tape with or without components shall pass around R without damage (see Figure 6).



## **Packaging Information Performance Notes**

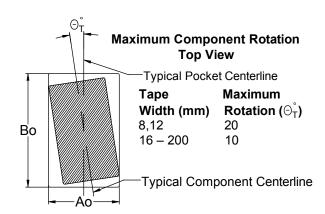
- 1. Cover Tape Break Force: 1.0 Kg minimum.
- 2. Cover Tape Peel Strength: The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength
8 mm	0.1 to 1.0 Newton (10 to 100 gf)
12 and 16 mm	0.1 to 1.3 Newton (10 to 130 gf)

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be 165 $^{\circ}$  to 180 $^{\circ}$  from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of 300  $\pm$ 10 mm/minute.

**3. Labeling:** Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards 556 and 624.* 

Figure 3 – Maximum Component Rotation



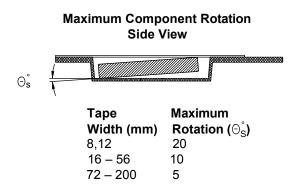


Figure 4 – Maximum Lateral Movement

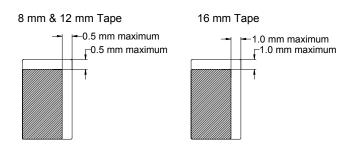
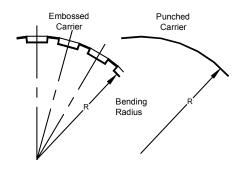
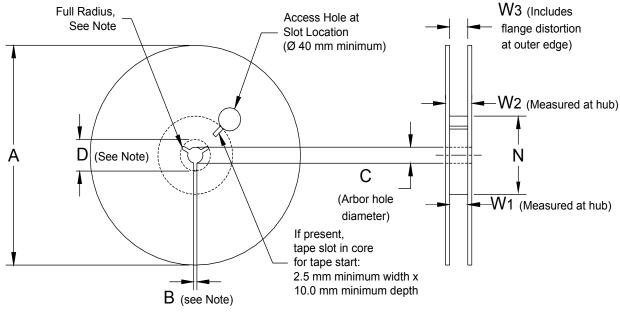


Figure 5 – Bending Radius





## Figure 6 - Reel Dimensions



Note: Drive spokes optional; if used, dimensions B and D shall apply.

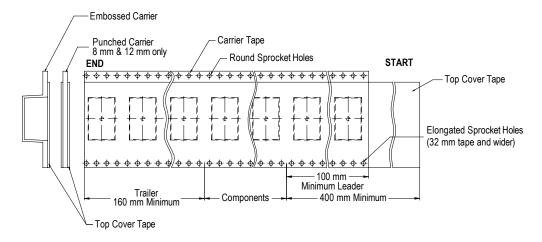
Table 8 - Reel Dimensions

Metric will govern

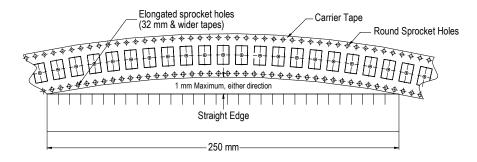
Constant Dimensions — Millimeters (Inches)						
Tape Size	A	B Minimum	С	D Minimum		
8 mm	178 ±0.20	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)		
12 mm	(7.008 ±0.008) or					
16 mm	330 ±0.20 (13.000 ±0.008)					
	Variable Dimensions — Millimeters (Inches)					
Tape Size	N Minimum	W <sub>1</sub>	W <sub>2</sub> Maximum	$W_3$		
8 mm		8.4 +1.5/-0.0 (0.331 +0.059/-0.0)	14.4 (0.567)			
12 mm	50 (1.969)	12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	Shall accommodate tape width without interference		
16 mm		16.4 +2.0/-0.0 (0.646 +0.078/-0.0)	22.4 (0.882)			



## Figure 7 - Tape Leader & Trailer Dimensions

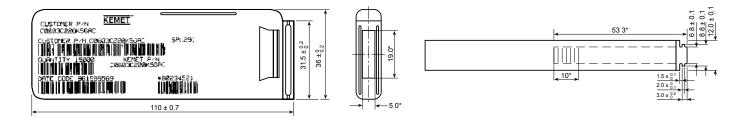


## Figure 8 – Maximum Camber



## **Bulk Cassette Packaging (Ceramic Chips Only)**

Meets Dimensional Requirements IEC–286 and EIAJ 7201 *Unit mm \*Reference* 



## **Capacitor Dimensions for Bulk Cassette**

Cassette Packaging - Millimeters

EIA Size Code	Metric Size Code	L Length	W Width	B Bandwidth	S Separation Minimum	T Thickness	Number of Pieces/Cassette
0402	1005	1.0 ±0.05	$0.5 \pm 0.05$	0.2 to 0.4	0.3	0.5 ±0.05	50,000
0603	1608	1.6 ±0.07	0.8 ±0.07	0.2 to 0.5	0.7	0.8 ±0.07	15,000



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Search Our FAQs: KnowledgeEdge	http://www.kemet.com/keask			
Electrolytic LifeCalculator	http://www.kemet.com:8080/elc			

Product Information			
Resource	Location		
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RoHS Statement	http://www.kemet.com/rohs		
Quality Documents	http://www.kemet.com/qualitydocuments		

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